Tel/tronix[®]

TekScope™ Analysis Datasheet

Analyze Anywhere Anytime



TekScope brings the power of the oscilloscope analysis environment to the PC. Users have the flexibility to perform analysis tasks including serial decode, power analysis, as well as timing, eye, and jitter analysis outside the lab. You can continue your session from your oscilloscope at any place and share the results. Reduces efforts to see screenshots when you need to dive deeper or while sharing. Reload the session on your 4/5/6 oscilloscope if you want to re-do the measurement.

Waveform data and setup in sessions from Tektronix 4/5/6 Series MSO, 5LP/6LPD Series MSO, and waveform data from 3 Series MDO. DPO/MSO/MDO3000, DPO/MSO/MDO4000, DPO7000C, or DPO/ MSO7000C/D/DX/SX Series Oscilloscopes can quickly be shared between team members and remote sites, resulting in improved efficiency.

Key features

Collaborate

- TekScope runs on your PC Enables better time and resource utilization; view, measure, and analyze data captured in your lab, independent of the oscilloscope hardware.
- Compatible with most common save/recall waveform files common analysis tools independent of the hardware acquisition, including:
 - .tss (4/5/6 Series session files setups and waveforms)
 - .wfm, .isf (Tektronix)
 - .bin (Keysight)
 - .trc (Lecroy)
 - .tr0 (Spice)
 - .csv (general purpose)

Analyze

- Cursors: Waveform, V Bars, H Bars, and V&H Bars
- Measurements: 34 standard
- Plots: Time Trend, Histogram, Spectrum, XY, and XYZ
- Math: Basic waveform arithmetic, FFT, and advanced equation
- Search: Quickly find events in your data based on specified
- Clocked/unclocked Parallel Bus Decode
- Optional Analysis Packages:
 - Multi-Scope Analysis: Remotely connect to multiple oscilloscopes to view and analyze real-time data from many channels simultaneously. Connect up to four oscilloscopes and 32 channels
 - Low Speed Protocol Decode: Protocol Decode and Search Analysis of all common Embedded, Automotive, Aerospace, Consumer and Audio protocols
 - Advanced Jitter Measurements and Eye Analysis
 - Power Electronic Analysis:
 - Advanced Power Analysis
 - Magnetics Analysis
 - Inverter Motor Drive Analysis
 - Power Integrity Analysis:
 - **Digital Power Management**
 - SPMI Serial Decode and Search
 - SpectrumView Analysis: Perform time and frequency domains simultaneously.
 - Remote Analysis for Bench Oscilloscopes: Use TekScope to remotely pull data from your bench oscilloscope and perform common serial decoding analysis.

Document

- Waveform and plot annotations Share detailed analysis results; measurements, anomalies and points of interest for future reference, collaboration with suppliers, or communicating with the team.
- Reports Easily document measurement results and configuration details with detailed test report.
- Custom Display configuration Group plots in multiple configurations with stacked or overlaid waveform view.

Applications and uses

- Offline Analysis: Analyze your waveform files from any location at any time to improve your working efficiency without any internet or intranet connection.
- Real-Time Analysis: Remotely connect to the newest and most modern Tektronix oscilloscopes to acquire data directly from oscilloscope in real-time. Save time and eliminate unnecessary trips to the lab with data available at your desk, at home, or while traveling.
- Multi-Scope Analysis: View and analyze data from multiple oscilloscopes on the same screen. Rearrange channel information, stack group, zoom, add cursors or measurements in a seamless interface. Increase your ability to look at a greater number of channels, all in a single view to accelerate your analysis efficiency.
- Data Sharing: Share waveforms, measurements, and configuration details among distributed team members or suppliers to root cause the source of failures. Dive into the actual data rather than using static screenshots and eyeballing images.
- Enhance your measurements and Analysis options: Not every oscilloscope has the latest and most modern software options, TekScope enables you to leverage our award-winning 4/5/6 Series user interface and software options and apply them to any Tektronix Oscilloscope and to most of competitors' oscilloscopes as well.

TekScope overview

Today's systems become more complex and teams are more distributed across geographies, functional areas of expertise, even partners and suppliers. As many engineers move to off-scope environments, TekScope allows the engineer to process, analyze, and share data efficiently, without having to be physically next to a oscilloscope or in the testing environment. The ease of operating with the TekScope software alongside other tools you use every day allows faster correlation and insight. These needs range from easy ways to share data, the ability to run measurements outside the lab, and methods to correlating lab measurements with simulation results.

Collaborate - TekScope runs on your PC, enabling analysis of data captured in your lab. Sessions can easily be saved on your Tektronix Oscilloscope and recalled at any given time. In addition to Tektronix waveforms, other file formats are supported including .wfm, .isf, .tss, .bin, .trc, .csv, and .tr0, to enable correlation.

Analyze - Measurements performed on TekScope use a common measurement library with 4/5/6 Series Tektronix Oscilloscope to correlate the results. TekScope supports a range of measurements including power, jitter, and eye measurements. Plots can be customized and are interactive with zoom and cursor controls allowing custom views to share.

Document - Results and views can be saved as a session file and archived for later use or sent to a colleague or supplier for a debug session. Alternatively, results can be archived and saved in the .pdf or the .mht format using the report generator. The report can be

customized to include the information of interest including: configuration details, measurement results, and plots. Plot and measurement data can also be saved to a .csv format file for archiving or data analysis in external applications.

Collaboration and setup sharing

Sharing data acquired on the oscilloscope for use with TekScope is as simple as saving 4/5/6 Series session and recalling in the application. Waveforms captured on any Tektronix oscilloscope can also be loaded using TekScope.

Workflow improvements

Sessions from the 4/5/6 Series Oscilloscope, enables improvements to your workflow. Saving a session from your oscilloscope is easily recalled in TekScope for further analysis and annotations. Using TekScope to tell your data story improves the ability to provide clarity over static images like screenshots. With a 4/5/6 Series Oscilloscope, you can also make changes to settings and restore your session back on your oscilloscope to resume where you left off without needing to reconfigure the oscilloscope from the beginning.

Analysis

Start to add annotations, measurements, decode, and plots after capturing your data. Free up your oscilloscope for colleagues, work from the comfort of your desk or even from home. By adding analysis when you want to, your data story unfolds for more flexibility in creating presentations and sharing results than relying only on static screenshots. Post-analysis lets you go back to past captures to double check results without needing to set up the oscilloscope again. Rather than starting from scratch when you do need to re-measure, simply reload your session file on the 4/5/6 Series MSO with any changes you need in settings and rapidly get back to work.

Measurements

Most oscilloscopes measure only on the first cycles of the waveform. TekScope measurement system allows measurements on all occurrences in the record. This improvement increases your measurement insights from all other waveforms and from other oscilloscopes. To gather measurement statistics, generates statistics from a single waveform rather than requiring multiple waveforms. Our measurement algorithms are also clearly documented in our Help system, which ensures the confidence in your results.

Reports for data archive

After completion of analysis, a report is generated to share or archive. Options, including the ability to include plots or configuration details, allow the user to specify the information that goes in the report. Reports can be archived as an .mht or .pdf file.



Figure 1: Complete test report includes setup details, measurement configuration and results, and plots

Waveform correlation between lab or simulation results

A common issue that arises when taking lab measurements is correlation between instrumentation and simulation. The source of differences can be related to a difference in measurement algorithms. TekScope allows the user to import multiple waveform formats from different sources, including .wfm, .isf, .tss, .csv, .bin, .trc, and .tr0, enabling the use of common analysis tools, eliminating the differences due to differing analysis tools. For example, the user can simultaneously compare the eye opening of a waveform captured in the lab vs. a simulated waveform or waveform captured on a different oscilloscope.

Multi-Scope remote analysis

Developing test applications that can support up many oscilloscope channels imposes feasibility challenges, long development times, and a long time to market. You can now add more channels to your testing environment while setting the multi-scope system to behave as one unit and save a lot of time analyzing many channels from different oscilloscopes and trying to synchronize all of them together.

View and analyze data from multiple oscilloscopes on the same screen. Rearrange channel information, stack group, zoom, add cursors or measurements in a seamless interface. This capability support up to four oscilloscopes and 32 channels.

The Multi-Scope Analysis solution enables you to remotely control the acquisition settings on all oscilloscopes simultaneously without the need to set up each oscilloscope individually. It provides a way to catch very fast glitches in high resolution across many channels at the same time. Once the data is acquired and captured on TekScope, you can

then run measurements and analysis across all channels from different oscilloscopes at once.



Figure 2: Performing three-unit remote oscilloscope analysis of 12 channels simultaneously

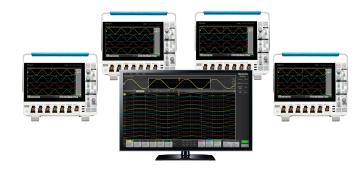


Figure 3: Multi-Scope solution - controlling up to four oscilloscopes to make a virtual 32channel instrument

Data transfer modes

1. Simple data transfer without triggering remote oscilloscopes – Get what you see on the oscilloscope.

[Use Refresh Waveforms button].

2. Acquire new waveform data upon triggering remote oscilloscopes. Trigger/Horizontal/Vertical settings are controlled by TekScope.

[Use Utility > I/O > TekScope Remote Control button set to ON and use Acquire button to acquire the data]

3. Acquire new waveform data upon triggering remote oscilloscopes. Trigger/Horizontal/Vertical settings are not controlled by TekScope, but instead TekScope uses the locally-configured settings on each oscilloscope.

[Use Utility > I/O > TekScope Remote Control button set to OFF and use **Acquire** button to acquire the data]

Synchronizing channels across instruments

For the Multi-Scope Analysis solution to be most accurate, it is important to set up your instruments so all channels can be tightly synchronized and less skewed. Skew is the time difference between instrument channels from the perfect ideal alignment. Deskewing removes different forms of error such as jitter, delta-time accuracy, and cable delay. There are multiple ways to skew channel data.

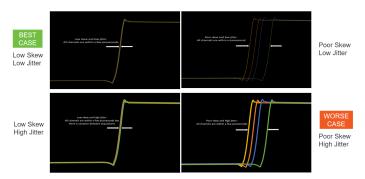


Figure 4: Examples for skew among channels

As time correlation among channels from different oscilloscopes is dependent on the instruments' setup, cases can range from 350 ps of skew between all channels using an easy setup to below 50 ps using a setup that involves more steps. Below you can find two edge examples:

350 ps Skew

Easy setup

- 1. Use matched phase cables into the Aux input.
- 2. Set Aux input for trigger.

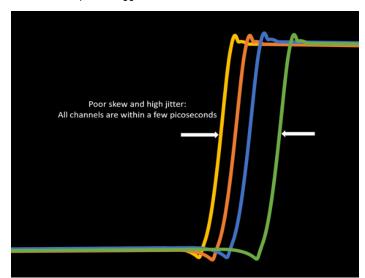


Figure 5: Demonstrating skew among channels using an easy setup



Figure 6: Setup diagram to quickly achieve moderate skew among channels

<50 ps Skew

Best performance setup

- 1. Use matched sync cables.
- 2. Use CH<x> for trigger (not aux input).
- 3. Deskew each CH to trigger input.
- Attach ref clock sync cable between instruments if capturing >2 μs of time.
- **5.** Measure to validate the amount of skew coming through all the channels.

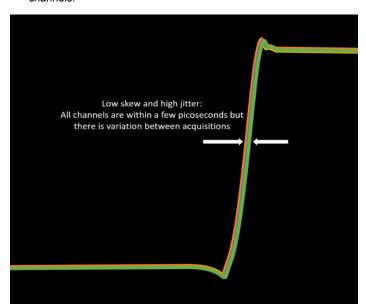


Figure 7: Demonstrating low skew among channels from different oscilloscopes

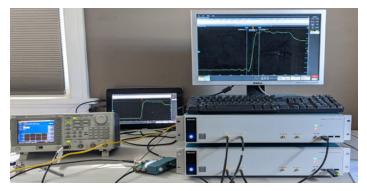


Figure 8: Setup example to achieve best skew performance

You can watch videos for more understanding on Multi-Scope Analysis.

- For Multi-Scope Analysis 24-channel example refer www.tek.com/ video/tekscope-multi-scope-analysis
- To know more on how to set up Multi-Scope Analysis on TekScope www.tek.com/video/how-to-set-up-multi-scope-analysis-ontekscope-pc-software%20

Serial protocol decode and analysis

Enhance your productivity through serial protocol decode tools to rapidly decode and search on results in your waveforms. Recognizing errors or correlating control results to other behaviors rapidly speeds up your ability to identify and resolve issues in your system.



Figure 9: Performing bus decode analysis and generating results table

Remote analysis for Bench oscilloscopes

In cases when your bench oscilloscope is missing serial decode options, you can now add them to your workflow by using TekScope.

TekScope allows you to remotely connect to your TBS/TPS/TDS 1000/2000 A/B/C oscilloscope and retrieve data in real-time. Once the data is automatically transferred into the TekScope software, you can continue run your decoding analysis for the most common serial protocols: I2C, SPI, RS-232/422/485/UART, CAN, CAN-FD, LIN. In addition, you will leverage our best-in-class and modern user interface for that purpose.

Customizable display

Waveform analysis is no longer constrained to a single oscilloscope display. TekScope allows you to control their analysis environment.

Two options are available for waveform viewing, either overlay mode or stacked mode. You can simply toggle between the two modes based on the required analysis. For example, when looking at edge crossings between two data signals, overlay mode may be preferred. As the number of waveforms grows, stacked mode is typically preferred.

Other scenarios require the evaluation of waveforms and plot data, including eye diagrams, spectrums, bathtub plots, or histograms. Plots can be viewed in the same window as the waveform or in cases where additional screen real estate is needed a group of plots can be created and displayed on a second monitor. Within the group of plots, the user has the flexibility to customize the layout by simply dragging and dropping the plots within the display. For example, as shown below when viewing the jitter spectrum or FFT of a waveform, a stacked view is preferred.

You can have a side-by-side view too.

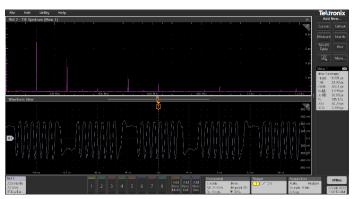


Figure 10: Stacked view of time domain waveform and jitter spectrum

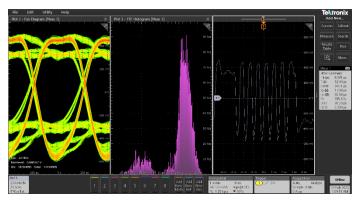


Figure 11: Side-by-side view of eye diagram, TIE histogram and waveform shown in individual views

When a single display is not sufficient to view the necessary plots, they can quickly be grouped and moved to a second monitor. Once grouped, the user has the flexibility to customize the layout and the ability to view the plots in either tabbed or grid mode. Tab mode provides a maximized view of an individual plot while allowing you to click on the other tabs to

toggle between the plots. Grid mode provides a single view of all the plots in the group.

Waveform zoom and cursors

Interactive plots with zoom and cursors - Plots provide a deep level of understanding of system behavior. It is often desired to zoom in on plot data, some common reasons to zoom on plots include placing cursors to take measurements at precise locations. Zooming enables precise viewing of the portion of the plot of interest. While zoomed in the overview window, it always provides context of the zoomed area in relation to the entire plot.

Cursor support for plots and waveforms can provide additional measurement details. For example, the amplitude and period of a waveform can be determined using cursors, or measurement results variation can be determined by evaluating the trend plot.



Figure 12: Cursor measurements with prominent readouts provide quick results for both plot and waveform data

Key capabilities

TekScope is available as a Free Base version with options to expand your analysis capabilities. The table summarizes the base capabilities:

Capabilities
View and annotate unlimited waveforms and plots
Zoom on waveforms and plots
View in stacked or overlay modes
Cursors: Waveform, V Bars, H Bars, V&H Bars
34 Amplitude and timing measurements with statistics
Math: Basic waveform arithmetic, FFT, and Equation editor
Plots: Time Trend, Histogram, Spectrum, and XY/XYZ
Search: Quickly find events in your data based on specified criteria
Import from and Export to a wide range of file formats
Decode clocked and Unclocked parallel bus
Table continued

Capabilities
FastFrame segmented memory
Generate reports
Edit your session file for recall on your oscilloscope - resume where you left off
Multiple-language support

Options	Capabilities included
Multi-Scope analysis	 Remote connection to the oscilloscopes. Remote Ethernet/USB connection. Real-time remote data acquisition. Support remote connection to four oscilloscopes and 32 channels. Shared view for all channels from different oscilloscopes simultaneously. Oscilloscope models supported:
	 4/5/6 Series MSO 5 Series Low-Profile MSO, 6 Series Low-Profile Digitizer DPO/MSO/DPS 70000 SX/DX/C TBS/TPS/TDS 1000 A/B/C, TBS/TPS/TDS 2000 A/B/C
Low Speed Protocol Decode	Protocol decode and Search analysis – I2C, I3C, SPI, RS-232, SPMI, I2S, LJ, RJ, TDM, CAN, CAN-FD, LIN, FlexRay, SENT, 100BASE-T1 Automotive Ethernet, MIL-STD-1553, ARINC-429, SpaceWire, USB 2.0, eUSB2, PSI5, SVID, 10BASE-T / 100BASE-TX Ethernet, MDIO, NRZ, 8b/10b, D-PHY, Manchester, SDLC.
Jitter measurements and analysis	Jitter, Eye, Amplitude, and Time measurements.
Power Electronics Analysis	 Advanced power analysis - Input, Amplitude, Timing, Switching, and Output measurements. Magnetics analysis - Inductance, Magnetic Property, Magnetic Loss, Current vs. Integral of Voltage measurements, and Plots. Inverter Motor Drive Analysis - Input, Ripple, and Output analysis.
Table continued	

Options	Capabilities included
Power Integrity Analysis	 Digital power management and analysis - Ripple, Transient, Power Sequence and Jitter analysis. SPMI Protocol decode and Search
SpectrumView analysis	You can perform Spectrum analysis from your PC. Refer www.tek.com/document/application-note/spectrum-view-new-approach-frequency-domain-analysis-oscilloscopes for Spectrum view datasheet.
Remote Analysis for Bench Oscilloscopes	Single remote Ethernet/USB connection to TBS/TPS/TDS 1000/2000 A/B/C oscilloscope. Real-time remote data acquisition. Serial bus decoding: I2C, SPI, RS-232/422/485/UART, CAN, CAN-FD, LIN.

Add analysis packages for the capabilities you need. Powerful additions are designed to save your time in protocol decode, power measurements, jitter analysis, and ensure that you have the tools you need at your fingertips.

Multi-Scope analysis provides you with the ability to remotely connect to four oscilloscopes and acquire 32-channel data directly from them without the need to manually load/recall waveforms.

Serial protocol enables faster time to answer by highlighting packet information and errors that can be correlated with events in your acquisitions. Decoded serial data may also be searched, enabling rapid identification of events in longer captures.

Power analysis enables deeper insight into the performance of your system with measurements and plots created with a power designer in mind.

TekScope with Jitter analysis uses the same DPOJET measurement framework available on Tektronix oscilloscopes. Comprehensive jitter and eye-diagram analysis, along with decomposition algorithms, simplify the discovery of signal integrity and jitter problems in today's high-speed serial, digital, and communication system designs.

Perform Spectrum view analysis from your local machine while having the option to work anywhere and apply these analysis capabilities on any historical data files.

Specifications

General

Specification type	Subtypes		Description
TekScope PC analysis software - Version	-		v 1.30.3.731
Time Measurements	22		Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Time, Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, Setup Time, Hold Time, Duration N-Periods, High Time, and Low Time
Amplitude Measurements	12		Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Base, and Area
Plots	5		Histogram, Spectrum ² , Eye Diagram ² , Bathtub ² , Time Trend, and XY/XYZ
Standard Math Functions	9		+, -, *, /, Integral, Derivative, Arbfilt, FFT Magnitude and Phase
Advanced Math Functions	33		^, <, <=, >, >=, ==, !=, Inv, (,), Time Point Gating (GATE {y1,y2} expression), log, In, Exp, Sqrt, Floor, Ceil, Fabs, Sin, Cos, Tan, Asin, Acos, Atan, Sinh, Cosh, Tanh, Intg, Diff, Min, Max, Avg, and - (negate)
Multi-Scope Analysis	-	General specifications	Maximum number of oscilloscopes: 4Maximum number of channels: 32
	-	Signal types	 Analog data - supported Digital data - not supported Spectrum data - not supported [Coming soon]
	-	Remote oscilloscope connection interfaces	 LAN - Using Ethernet connection USB - Using automatic connection discovery
	-	Oscilloscope models	 4/5/6 Series MSO 5 Series Low-Profile MSO, 6 Series Low-Profile Digitizer DPO/MSO/DPS 70000 SX/DX/C TBS/TPS/TDS 1000 A/B/C, TBS/TPS/TDS 2000 A/B/C
	-	Data transfer modes	 Refresh waveforms - simple data transfer without triggering remote oscilloscopes. Acquire new waveform data upon triggering remote oscilloscopes; TekScope controls acquisition settings across all connected oscilloscopes. Acquire new waveform data upon triggering remote oscilloscopes; TekScope does not control acquisition settings of connected oscilloscopes - using the acquisition settings configured locally in the oscilloscopes.

² only available in Jitter Analysis

Specification type	Subtypes		Description
Power Electronics	4	Input Analysis	Power Quality, Harmonics, Inrush Current, and Input Capacitance
Measurements and Analysis	6	Amplitude Analysis	Cycle Amplitude, Cycle Top, Cycle Base, Cycle Peak-to-Peak, Cycle Maximum, and Cycle Minimum
	5	Timing Analysis	Period, Frequency, Positive Duty Cycle, Negative Duty Cycle, Positive Pulse Width, and Negative Pulse Width
	5	Switching Analysis	Switching Loss, dv/dt, di/dt, SOA, and RDS(on)
	4	Magnetic Analysis	Inductance, Magnetic Property, Magnetic Loss, and Current vs. Integral of Voltage Plot
	5	Output Analysis	Line Ripple, Switching Ripple, Efficiency, Turn On Time, and Turn Off Time
	5	Inverter Motor Drive Analysis	Power Quality, Harmonics, Ripple, Efficiency, DQ0
Power Integrity	1	Ripple Analysis	Ripple
Measurements and Analysis	4	Transient Analysis	Overshoot, Undershoot, Turn on Overshoot, and DC Rail Voltage
	2	Power Sequence Analysis	Turn On Time and Turn Off Time
	8	Jitter analysis	TIE, PJ, RJ, DJ, Eye Height, Eye Width, Eye High, and Eye Low
	1	Protocol Decode and Search Analysis	SPMI Protocol
Jitter Measurements and Analysis	18	Jitter Measurements	Jitter Summary, TIE, Phase Noise, TJ@BER, RJ-δδ, DJ-δδ, PJ, RJ, DJ, DDJ, DCD, SRJ, J2, J9, NPJ, F/2, F/4, and F/8
	7	Eye Measurements	Eye Height, Eye Width, Eye High, Eye Height@BER, Eye Width@BER, Eye Low, and Q-Factor
	7	Amplitude Measurements	Bit High, Bit Low, Bit Amplitude, DC Common Mode, AC Common Mode (Pk-Pk), Differential Crossover, and T/nT Ratio
	2	Time Measurements	SSC Freq Deviation, SSC Modulation Rate
Low Speed Protocol Decode	29	Protocol Decode and Search Analysis	I2C, I3C, SPI, RS-232, SPMI, I2S, LJ, RJ, TDM, CAN, CAN-FD, LIN, FlexRay, SENT, 100BASE-T1 Automotive Ethernet, MIL-STD-1553, ARINC-429, SpaceWire, USB 2.0, eUSB2, PSI5, SVID, 10BASE-T / 100BASE-TX Ethernet, MDIO, NRZ, 8b/10b, D-PHY, Manchester, SDLC.

Specification type	Subtypes		Description
Remote Analysis for Bench Oscilloscopes	-	General specifications	Maximum number of oscilloscopes: 1Maximum number of channels: 4
	6	Protocol Decode and Search Analysis	I2C, SPI, RS-232/422/485/UART, CAN, CAN-FD, LIN
	-	Signal types	 Analog data - supported Digital data - not supported Spectrum data - not supported
	-	Remote oscilloscope connection interfaces	 LAN - Using Ethernet connection USB - Using automatic connection discovery
	-	Oscilloscope models	TBS/TPS/TDS 1000 A/B/C, TBS/TPS/TDS 2000 A/B/C.
	-	Data transfer modes	 Refresh waveforms - simple data transfer without triggering remote oscilloscope. Acquire new waveform data upon triggering remote oscilloscope; TekScope controls acquisition settings of connected oscilloscope. Acquire new waveform data upon triggering remote oscilloscope; TekScope does not control acquisition settings of connected oscilloscope - using the acquisition settings configured locally in the oscilloscope.
Supported file types	7	Import	 .tss (Tektronix 4/5/6 Series session) .wfm, .isf (Tektronix) .bin (Keysight) .trc (Lecroy) .tr0 (Spice) .csv (general purpose)
	10	Export	.jpg, .bmp, and .png (Screen Capture - Save to PC drive, not to oscilloscope memory) .wfm (Tektronix Waveform Data) .csv, .mat (Waveform Data to CSV or Matlab format) .set (Setup Information) .tss (Tektronix 4/5/6 Series Session) .pdf, .mht (Reports)
Programmable Interface	-		All optional premium licenses on TekScope include Programmable Interface for automated testing. The Programmable Interface will run on your PC and communicate with the TekScope software. Find out more in the Programmer manual: .www.tek.com/manual/oscilloscope/4-5-6-series-mso-5-series-mso-mixed-signal-oscilloscope
4/5/6 Series MSO firmware version compatibility	-	v 1.30.3	Exclusions:Frequency Response Analysis (FRA)Mask testing

Waveform Controls

Zoom Horizontal and/or Vertical

Cursors Waveform or Screen

Plot controls

Zoom Horizontal and/or Vertical

Cursors Waveform or Screen

Number of views

Waveform views One with the ability to configure in stacked, overlay or mixed modes. Up to 32 waveforms are viewed

simultaneously

Available outputs

Report Comprehensive report with measurement results, plots, and system configuration details are available in .pdf

or .mht formats

Composite Setup Single file for saving waveforms, measurements, and configuration details

Plot and Measurement Data Export plot and measurement data in .csv formats

Minimum system configuration

System requirements 64-bit Windows 10

8 GB or higher of RAM recommended

Intel® Core™ i5 or AMD Athlon® X4 processor (2GHz or faster)

5 GB of available hard disk space, 10 GB recommended (exact space is dependent on the number of

waveforms and their size)

1920x1080 or greater at 100% scaling recommended OpenGL® 2.0, 32-bit color, and 1 GB of VRAM

Internet Browser - Chrome or Firefox (for software and license download)³

³ Internet connection is needed to download the software and any license file. Once completed, Internet connection will no longer be needed. The software does not require online Internet connectivity in order to use it for its regular operation.

Ordering information

Register and download TekScope PC Software at www.tek.com/software/tekscope-pc-analysis-software. Software is enabled by a license file that can be downloaded from the TekCloud website using a trial or a paid license.

Base license

Product	Description	License Option
TekScope	TekScope PC Waveform Analysis Software - Base License	Available by default

Optional premium licenses⁴

Product	Description	License Term	License Option
Multi-Scope Analysis	License; Multi-Scope Analysis License, Viewing	1-Year Time-Based	TEKSCOPE-MULTI-1YR
	and Analysis of Real-time Channels from Multiple Remote Scopes Simultaneously; 2 Individual Seats, Node Locked.	Perpetual	TEKSCOPE-MULTI-PER
Low Speed Protocol Decode	License; Low Speed Protocol Decode - I2C,	1-Year Time-Based	TEKSCOPE-DECODE-1YR
	I3C, SPI, RS-232, SPMI, I2S, LJ, RJ, TDM, CAN, CAN-FD, LIN, FlexRay, SENT, 100BASE-T1 Automotive Ethernet, MIL-STD-1553, ARINC-429, SpaceWire, USB 2.0, eUSB2, PSI5, SVID, 10BASE-T / 100BASE-TX Ethernet, MDIO, NRZ, 8b/10b, D-PHY, Manchester, SDLC; 2 Individual Seats, Node Locked	Perpetual	TEKSCOPE-DECODE-PER
Jitter Measurements and	License; Advanced Jitter and Eye Analysis; 2	1-Year Time-Based	TEKSCOPE-DJA-1YR
Analysis	Individual Seats, Node Locked	Perpetual	TEKSCOPE-DJA-PER
Power Electronics Analysis	License; Power Electronics: Advanced Power	1-Year Time-Based	TEKSCOPE-PWR-ELC-1YR
	Analysis, Magnetics Analysis, Inverter Motor Drive Analysis; 2 Individual Seats, Node Locked	Perpetual	TEKSCOPE-PWR-ELC-PER
Power Integrity Analysis	License; Power Integrity: Digital Power	1-Year Time-Based	TEKSCOPE-PWR-INT-1YR
	Management and Analysis, Power Management Serial Decode and Analysis (SPMI); 2 Individual Seats, Node Locked	Perpetual	TEKSCOPE-PWR-INT-PER
SpectrumView Analysis	License; SpectrumView Application; 2	1-Year Time-Based	TEKSCOPE-SV-1YR
	Individual Seats, Node Locked	Perpetual	TEKSCOPE-SV-PER
Remote Analysis for Bench	License; Real-Time Remote Data Acquisition	1-Year Time-Based	TEKSCOPE-ENTRY-1YR
Oscilloscopes	from a Single TBS/TDS/TPS Oscilloscope, Essential Protocol Decoders - I2C, SPI, UART, CAN, CAN-FD, LIN; 2 Individual Seats, Node Locked	Perpetual	TEKSCOPE-ENTRY-PER

⁴ All optional premium licenses include Programmable Interface commands used for automated testing. Find out more in the Programmer Manual: www.tek.com/manual/ oscilloscope/4-5-6-series-mso-5-series-mso-mixed-signal-oscilloscope.

Installing prerequisite software

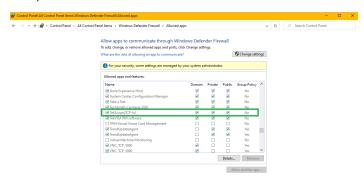
Pay special attention to installing the prerequisite software needed in order to run properly any licenses you have subscribed to on TekScope. The prerequisite software needed can be downloaded from: scope.tekcloud.com/#/help/prerequisites (you need to sign in first to your account to watch this page).

Required software

- Required for Multi-Scope Analysis and Remote Analysis for Bench Oscilloscopes licenses:
 - a. TekVISA
 - b. PortMapper Service
- 2. Required for Programmable Interface functionality: TekVISA

Recommendation for using Multi-Scope Analysis and Remote Analysis for Bench Oscilloscopes licenses

The company's IT firewall settings sometimes impact the ability to remotely connect to your oscilloscopes. To overcome this challenge, make sure Domain, Private and Public checkboxes are all checked for the TekScope application in your Windows firewall list. Look at the below image for an example



License activation

The Base License is available at no cost⁵.

Advanced licenses are available for a 14-day trial at no cost. At the end of the 14-day trial, you may continue using the licenses after purchasing them.

Customers can purchase advanced licenses in one of two ways:

Placing a Purchase Order (PO) with any Tektronix Sales channels. Upon placing a PO, you will receive a software activation key. The activation key can be entered during the sign-up process or after your account is set up.



Using a credit card directly on the TekCloud website [Available only to U.S. Customers].

⁵ Tektronix reserves the right to modify or cancel the free Base License and the 14-day trial offer for the advanced licenses at any time.



Add Payment Method

Card number		MM/YY CVC
	Cancel	Add Ca

License types and software updates

The following definitions apply to the TekScope license types:

Perpetual License: Use the software indefinitely; License does not expire but maintenance (updates/support) only available for the first 12-months. Support can be extended by purchasing a Maintenance License. If a Perpetual License goes out of support, all features will be frozen to the last released version before the support expired. The software will continue to work, but you cannot get any updates newer than the support expiration date.

Maintenance License: Apply to Perpetual Licenses only. Maintenance License is an extension license that extends the period of support of an original perpetual license for 12 months.

Time-Based License: Use the software throughout the term of the license. Software maintenance (updates/support) through the term of the license are included. When the Time-Based License expires, all features will no longer work, but a new Time-Based License may be purchased.

Every TekScope license is a Node-Locked License and is used on a PC. Upon purchasing a TekScope license, you have the option to use it for two software installations on individual PCs. However, bear in mind that these are not floating or enterprise licenses that can be moved from one PC to another. Customers can install the license on two different PCs or on the same PC while using two different users to log into this PC. Once installed, these two software installations can be used simultaneously.







Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

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For Further Information. Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit www.tek.com.

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